

BUH100

SWITCHMODE™ NPN Silicon Planar Power Transistor

The BUH100 has an application specific state-of-art die designed for use in 100 Watts Halogen electronic transformers.

This power transistor is specifically designed to sustain the large inrush current during either the startup conditions or under a short circuit across the load.

Features

- Improved Efficiency Due to the Low Base Drive Requirements:
 - High and Flat DC Current Gain h_{FE}
 - Fast Switching
- Robustness Thanks to the Technology Developed to Manufacture this Device
- ON Semiconductor Six Sigma Philosophy Provides Tight and Reproducible Parametric Distributions
- Pb-Free Package is Available*

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector-Emitter Sustaining Voltage	V_{CEO}	400	Vdc
Collector-Base Breakdown Voltage	V_{CBO}	700	Vdc
Collector-Emitter Breakdown Voltage	V_{CES}	700	Vdc
Emitter-Base Voltage	V_{EBO}	10	Vdc
Collector Current – Continuous	I_C	10	Adc
– Peak (Note 1)	I_{CM}	20	
Base Current – Continuous	I_B	4	Adc
– Peak (Note 1)	I_{BM}	10	
Total Device Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	P_D	100 0.8	W W/ $^\circ\text{C}$
Operating and Storage Temperature	T_J, T_{stg}	-60 to 150	$^\circ\text{C}$

THERMAL CHARACTERISTICS

Characteristics	Symbol	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	1.25	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	62.5	$^\circ\text{C/W}$
Maximum Lead Temperature for Soldering Purposes 1/8" from Case for 5 Seconds	T_L	260	$^\circ\text{C}$

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

1. Pulse Test: Pulse Width = 5 ms, Duty Cycle \leq 10%.

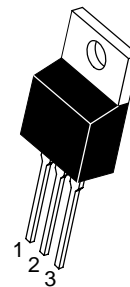
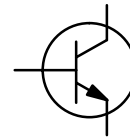
*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



ON Semiconductor®

<http://onsemi.com>

POWER TRANSISTORS
10 AMPERES
700 VOLTS – 100 WATTS



TO-220AB
CASE 221A-09
STYLE 1

MARKING DIAGRAM



A = Assembly Location
Y = Year
WW = Work Week
G = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping
BUH100	TO-220AB	50 Units / Rail
BUH100G	TO-220AB (Pb-Free)	50 Units / Rail

BUH100

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Collector-Emitter Sustaining Voltage ($I_C = 100\text{ mA}$, $L = 25\text{ mH}$)	$V_{CEO(sus)}$	400	460		Vdc
Collector-Base Breakdown Voltage ($I_{CBO} = 1\text{ mA}$)	V_{CBO}	700	860		Vdc
Emitter-Base Breakdown Voltage ($I_{EBO} = 1\text{ mA}$)	V_{EBO}	10	12.5		Vdc
Collector Cutoff Current ($V_{CE} = \text{Rated } V_{CEO}$, $I_B = 0$)	I_{CEO}			100	μAdc
Collector Cutoff Current ($V_{CE} = \text{Rated } V_{CES}$, $V_{EB} = 0$)	I_{CES}			100 1000	μAdc
Collector Base Current ($V_{CB} = \text{Rated } V_{CBO}$, $V_{EB} = 0$)	I_{CBO}			100 1000	μAdc
Emitter-Cutoff Current ($V_{EB} = 9\text{ Vdc}$, $I_C = 0$)	I_{EBO}			100	μAdc

ON CHARACTERISTICS

Base-Emitter Saturation Voltage ($I_C = 5\text{ Adc}$, $I_B = 1\text{ Adc}$)	@ $T_C = 25^\circ\text{C}$	$V_{BE(sat)}$		1	1.1	Vdc
Collector-Emitter Saturation Voltage ($I_C = 5\text{ Adc}$, $I_B = 1\text{ Adc}$) ($I_C = 7\text{ Adc}$, $I_B = 1.5\text{ Adc}$)	@ $T_C = 25^\circ\text{C}$ @ $T_C = 125^\circ\text{C}$	$V_{CE(sat)}$		0.37 0.37	0.6 0.6	Vdc
	@ $T_C = 25^\circ\text{C}$ @ $T_C = 125^\circ\text{C}$			0.5 0.6	0.75 1.5	Vdc
DC Current Gain ($I_C = 1\text{ Adc}$, $V_{CE} = 5\text{ Vdc}$) ($I_C = 5\text{ Adc}$, $V_{CE} = 5\text{ Vdc}$) ($I_C = 7\text{ Adc}$, $V_{CE} = 5\text{ Vdc}$) ($I_C = 10\text{ Adc}$, $V_{CE} = 5\text{ Vdc}$)	@ $T_C = 25^\circ\text{C}$ @ $T_C = 125^\circ\text{C}$	h_{FE}	15 16	24 28		
	@ $T_C = 25^\circ\text{C}$ @ $T_C = 125^\circ\text{C}$		10 10	15 14.5		
	@ $T_C = 25^\circ\text{C}$ @ $T_C = 125^\circ\text{C}$		8 7	12 10.5		
	@ $T_C = 25^\circ\text{C}$ @ $T_C = 125^\circ\text{C}$		6 4	9.5 8		

DYNAMIC SATURATION VOLTAGE

Dynamic Saturation Voltage: Determined 3 μs after rising I_{B1} reaches 90% of final I_{B1} (See Figure 19)	$I_C = 5\text{ Adc}$, $I_{B1} = 1\text{ Adc}$ $V_{CC} = 300\text{ V}$	@ $T_C = 25^\circ\text{C}$	$V_{CE(dsat)}$		1.1		V
		@ $T_C = 125^\circ\text{C}$			2.1		V
	$I_C = 7.5\text{ Adc}$, $I_{B1} = 1.5\text{ Adc}$ $V_{CC} = 300\text{ V}$	@ $T_C = 25^\circ\text{C}$			1.7		V
		@ $T_C = 125^\circ\text{C}$			5		V

DYNAMIC CHARACTERISTICS

Current Gain Bandwidth ($I_C = 1\text{ Adc}$, $V_{CE} = 10\text{ Vdc}$, $f = 1\text{ MHz}$)	f_T		23		MHz
Output Capacitance ($V_{CB} = 10\text{ Vdc}$, $I_E = 0$, $f = 1\text{ MHz}$)	C_{ob}		100	150	pF
Input Capacitance ($V_{EB} = 8\text{ Vdc}$, $f = 1\text{ MHz}$)	C_{ib}		1300	1750	pF

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ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Typ	Max	Unit
SWITCHING CHARACTERISTICS: Resistive Load (D.C. ≤ 10%, Pulse Width = 40 μs)						
Turn-on Time	I _C = 1 Adc, I _{B1} = 0.2 Adc I _{B2} = 0.2 Adc V _{CC} = 300 Vdc	@ T _C = 25°C	t _{on}	130	200	ns
Turn-off Time		@ T _C = 125°C	t _{off}	6.8 8.5	8	μs
Turn-on Time	I _C = 1 Adc, I _{B1} = 0.2 Adc I _{B2} = 0.4 Adc V _{CC} = 300 Vdc	@ T _C = 25°C	t _{on}	140	200	ns
Turn-off Time		@ T _C = 125°C	t _{off}	3.4 4.3	4	μs
Turn-on Time	I _C = 5 Adc, I _{B1} = 1 Adc I _{B2} = 1 Adc V _{CC} = 300 Vdc	@ T _C = 25°C	t _{on}	250	500	ns
Turn-off Time		@ T _C = 125°C	t _{off}	2.9 3.6	3.5	μs
Turn-on Time	I _C = 7.5 Adc, I _{B1} = 1.5 Adc I _{B2} = 1.5 Adc V _{CC} = 300 Vdc	@ T _C = 25°C	t _{on}	500	700	ns
Turn-off Time		@ T _C = 125°C	t _{off}	2.1 2.5	2.5	μs

SWITCHING CHARACTERISTICS: Inductive Load (V_{clamp} = 300 V, V_{CC} = 15 V, L = 200 μH)

Fall Time	I _C = 1 Adc I _{B1} = 0.2 Adc I _{B2} = 0.2 Adc	@ T _C = 25°C	t _{fi}	150	250	ns
Storage Time		@ T _C = 125°C	t _{si}	5.1 5.8	6	μs
Crossover Time		@ T _C = 25°C	t _c	230 300	325	ns
Fall Time	I _C = 1 Adc I _{B1} = 0.2 Adc I _{B2} = 0.5 Adc	@ T _C = 25°C	t _{fi}	150	250	ns
Storage Time		@ T _C = 125°C	t _{si}	2.5 2.8	3	μs
Crossover Time		@ T _C = 25°C	t _c	260 300	350	ns
Fall Time	I _C = 5 Adc I _{B1} = 1 Adc I _{B2} = 1 Adc	@ T _C = 25°C	t _{fi}	100	150	ns
Storage Time		@ T _C = 125°C	t _{si}	2.9 4.6	3.5	μs
Crossover Time		@ T _C = 25°C	t _c	220 450	300	ns
Fall Time	I _C = 7.5 Adc I _{B1} = 1.5 Adc I _{B2} = 1.5 Adc	@ T _C = 25°C	t _{fi}	100	150	ns
Storage Time		@ T _C = 125°C	t _{si}	2 2.5	2.5	μs
Crossover Time		@ T _C = 25°C	t _c	250 475	350	ns

TYPICAL STATIC CHARACTERISTICS

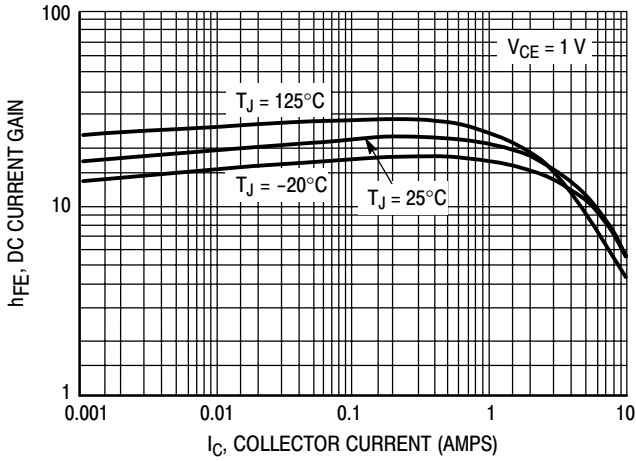


Figure 1. DC Current Gain @ 1 Volt

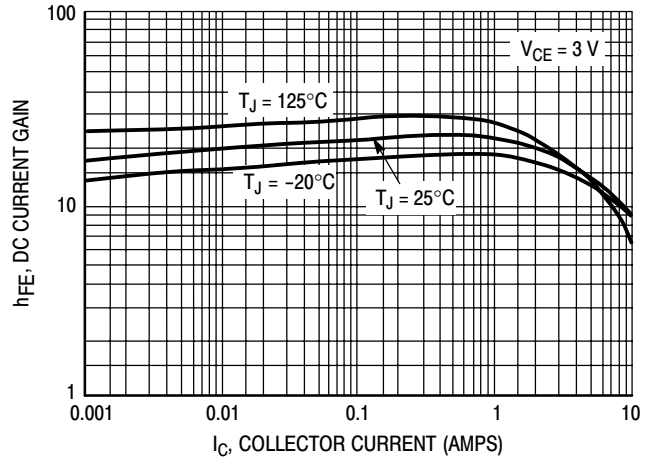


Figure 2. DC Current Gain @ 3 Volt

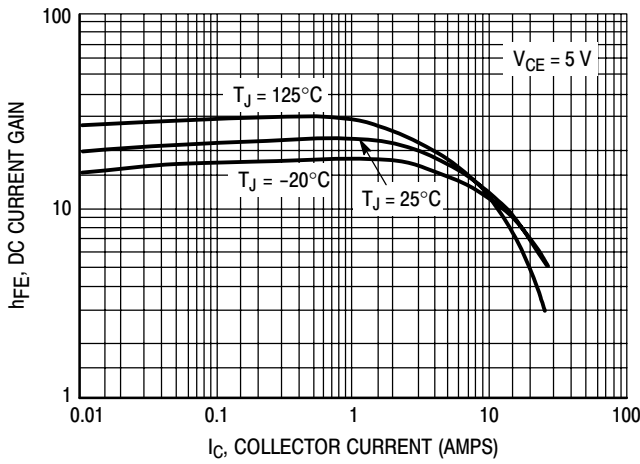


Figure 3. DC Current Gain @ 5 Volt

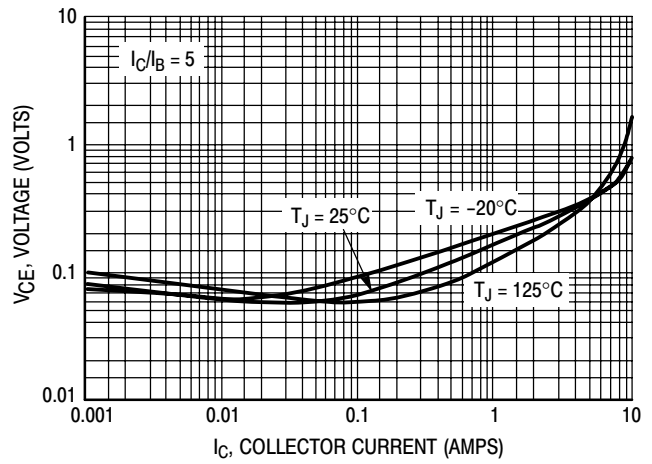


Figure 4. Collector-Emitter Saturation Voltage

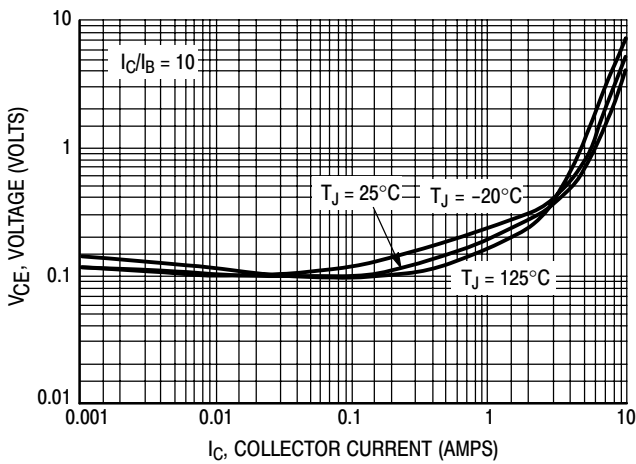


Figure 5. Collector-Emitter Saturation Voltage

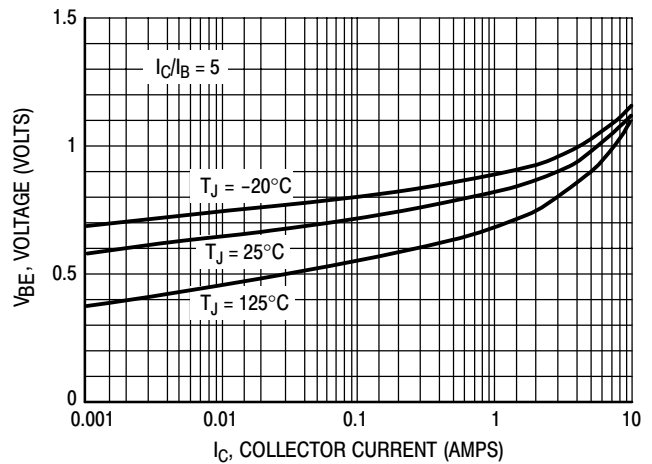


Figure 6. Base-Emitter Saturation Region

TYPICAL STATIC CHARACTERISTICS

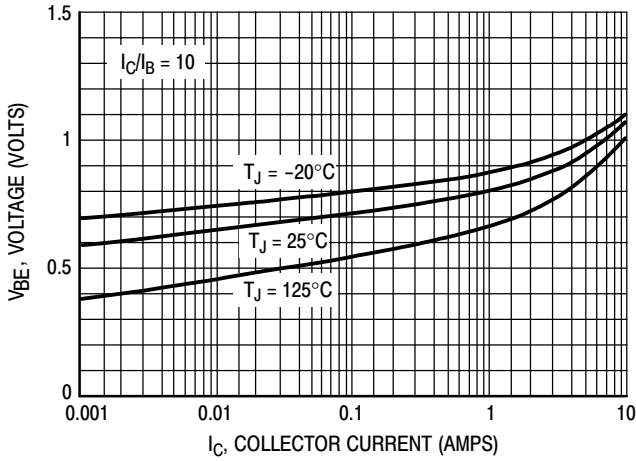


Figure 7. Base-Emitter Saturation Region

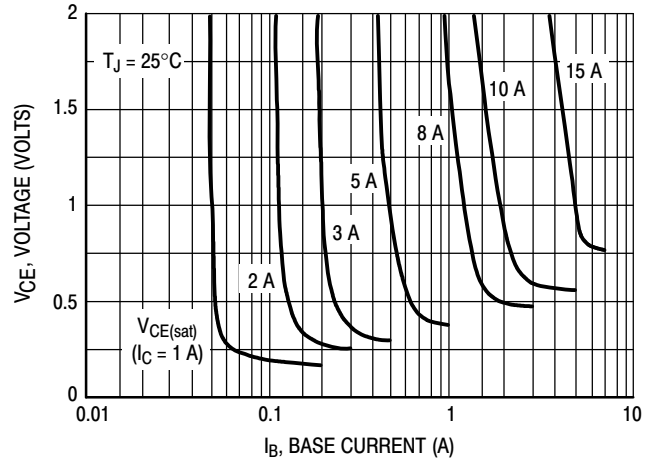


Figure 8. Collector Saturation Region

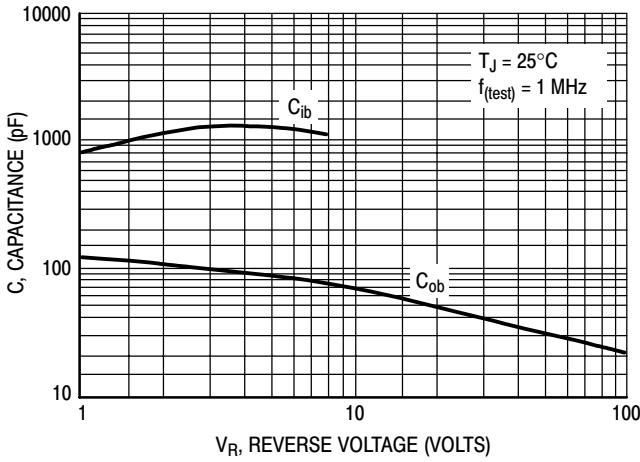


Figure 9. Capacitance

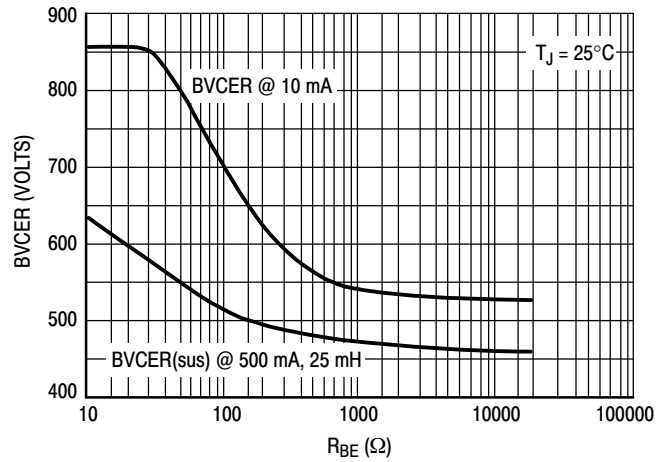


Figure 10. Resistive Breakdown

TYPICAL SWITCHING CHARACTERISTICS

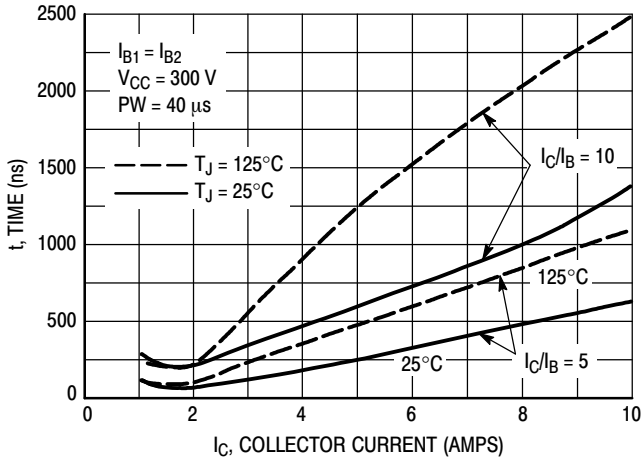


Figure 11. Resistive Switching Time, t_{on}

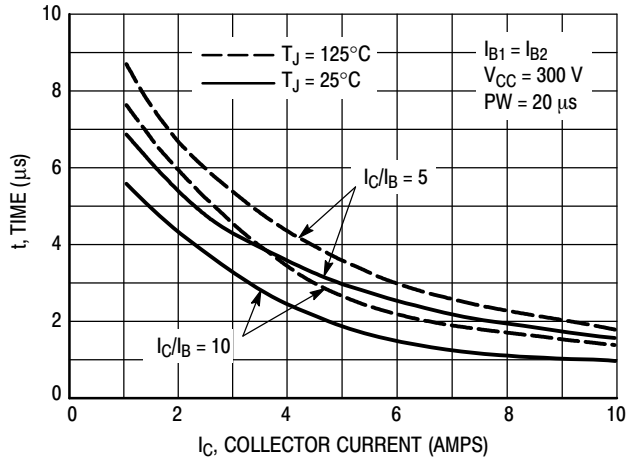


Figure 12. Resistive Switch Time, t_{off}

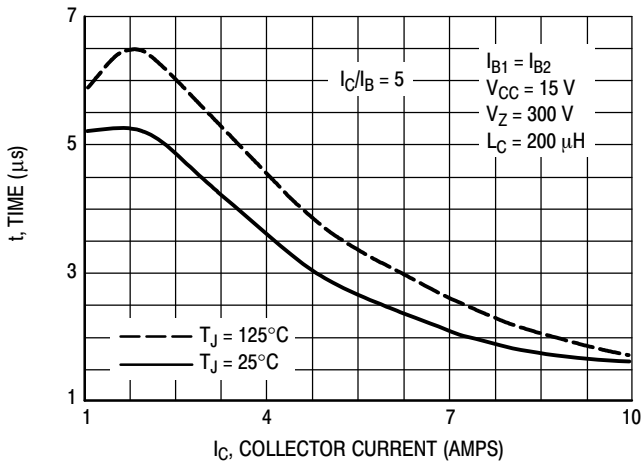


Figure 13. Inductive Storage Time, t_{si}

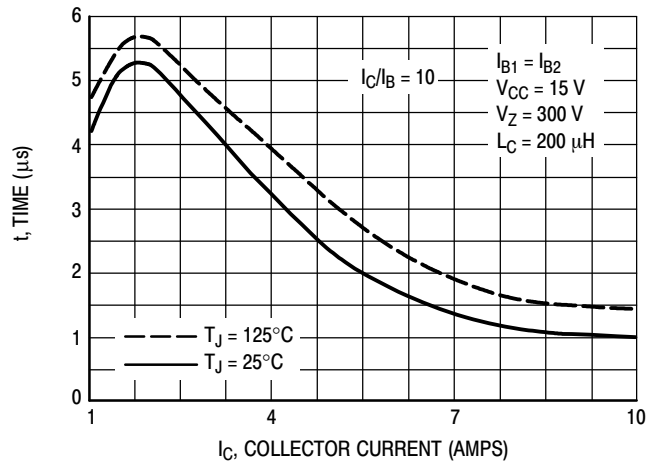


Figure 13 Bis. Inductive Storage Time, t_{si}

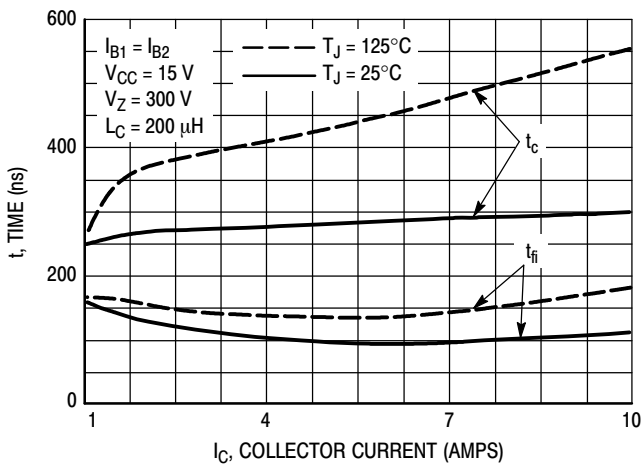


Figure 14. Inductive Storage Time, t_c & t_{fi} @ $I_C/I_B = 5$

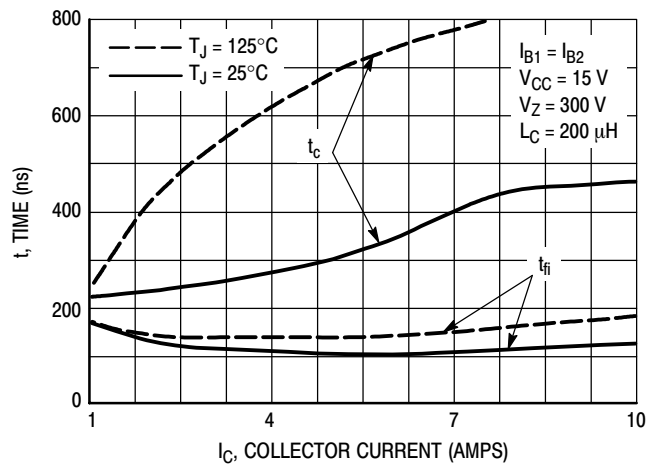


Figure 15. Inductive Storage Time, t_c & t_{fi} @ $I_C/I_B = 10$

TYPICAL SWITCHING CHARACTERISTICS

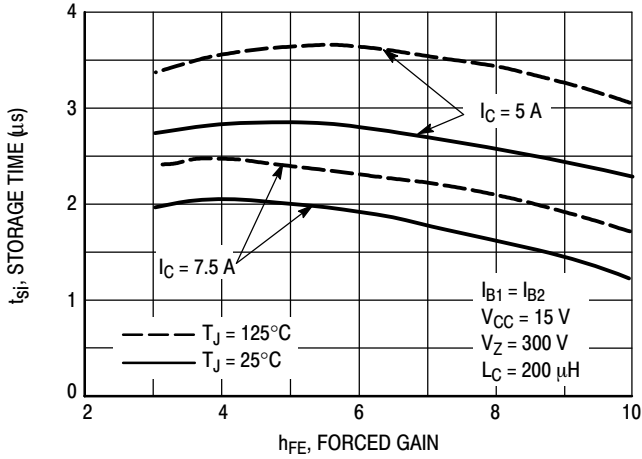


Figure 16. Inductive Storage Time

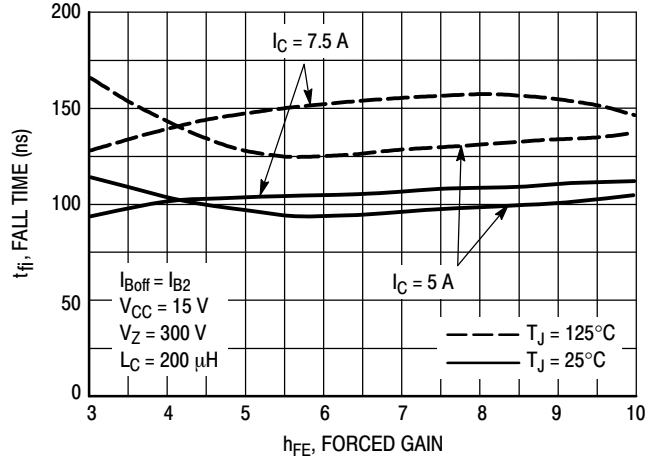


Figure 17. Inductive Fall Time

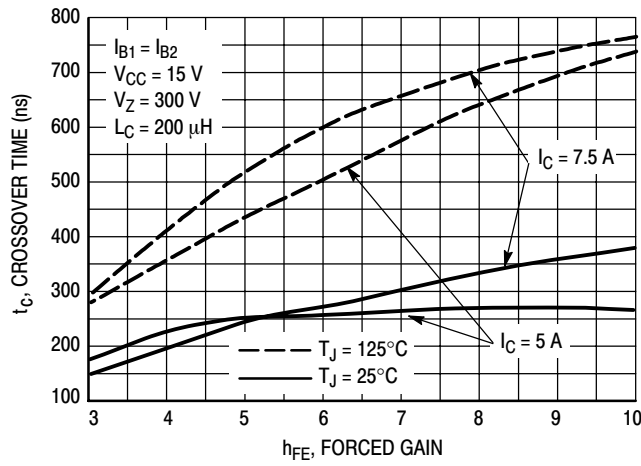


Figure 18. Inductive Crossover Time, t_c

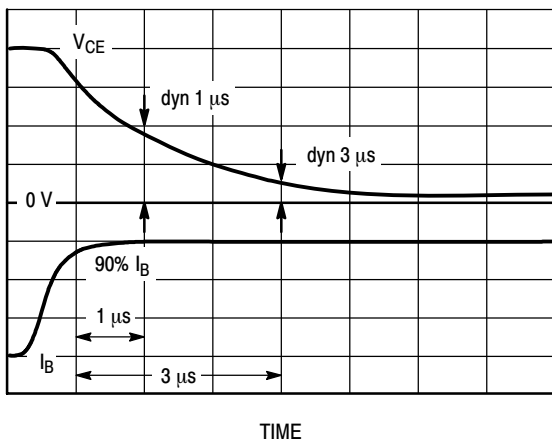


Figure 19. Dynamic Saturation Voltage Measurements

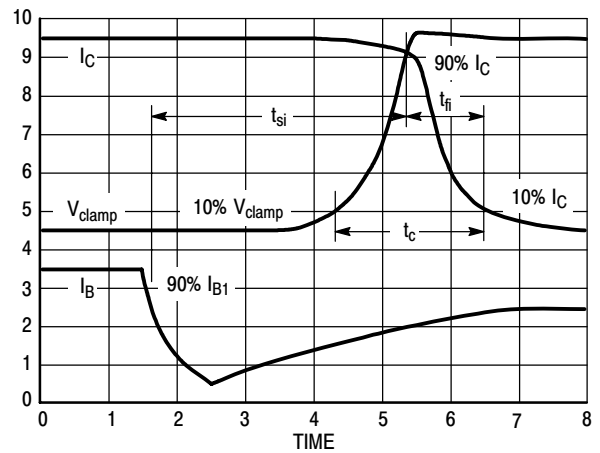
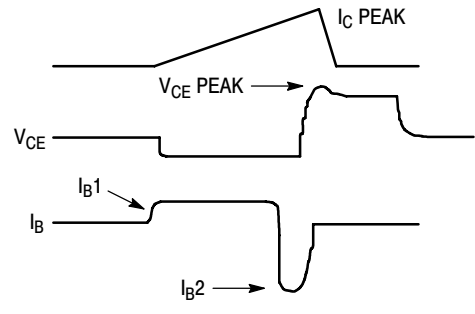
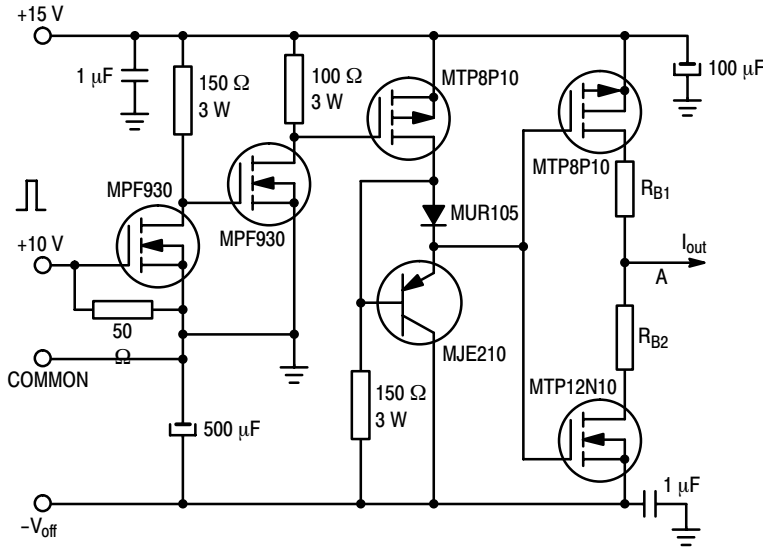


Figure 20. Inductive Switching Measurements

Table 1. Inductive Load Switching Drive Circuit



$V_{(BR)CEO(sus)}$	Inductive Switching	RBSOA
$L = 10 \text{ mH}$	$L = 200 \mu\text{H}$	$L = 500 \mu\text{H}$
$R_{B2} = \infty$	$R_{B2} = 0$	$R_{B2} = 0$
$V_{CC} = 20 \text{ V}$	$V_{CC} = 15 \text{ V}$	$V_{CC} = 15 \text{ V}$
$I_{C(pk)} = 100 \text{ mA}$	R_{B1} selected for desired I_{B1}	R_{B1} selected for desired I_{B1}

TYPICAL THERMAL RESPONSE

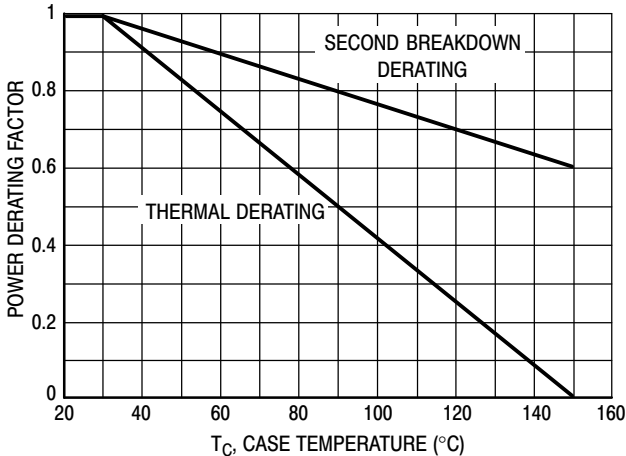


Figure 21. Forward Bias Power Derating

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I_C-V_{CE} limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate. The data of Figure 22 is based on $T_C = 25^\circ\text{C}$; $T_{J(pk)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when $T_C > 25^\circ\text{C}$. Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown on Figure 22 may be found at any case temperature by using the appropriate curve on Figure 21.

$T_{J(pk)}$ may be calculated from the data in Figure 24. At any case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown. For inductive loads, high voltage and current must be sustained simultaneously during turn-off with the base to emitter junction reverse biased. The safe level is specified as a reverse biased safe operating area (Figure 23). This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode.

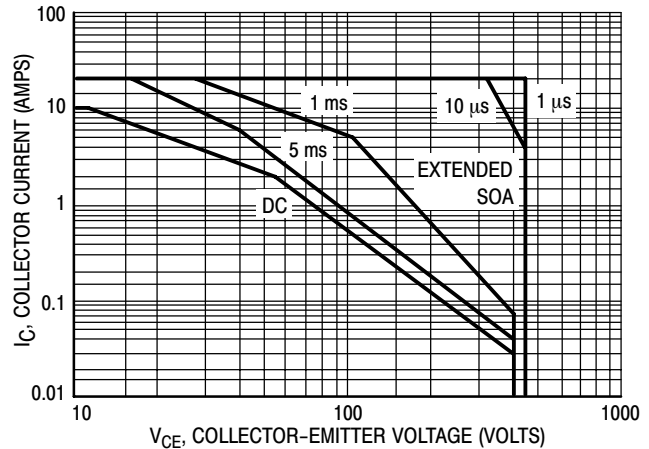


Figure 22. Forward Bias Safe Operating Area

BUH100

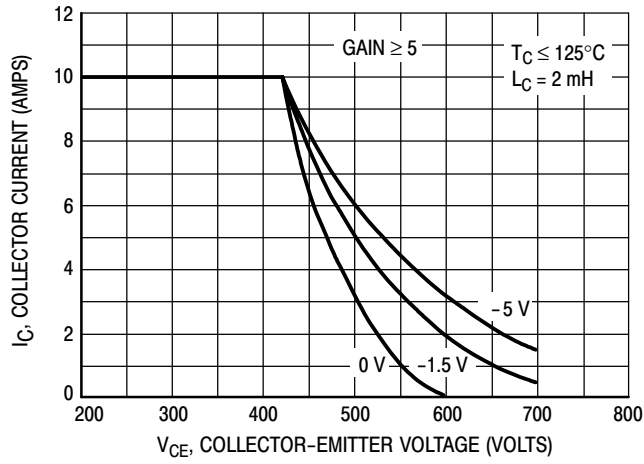


Figure 23. Reverse Bias Safe Operating Area

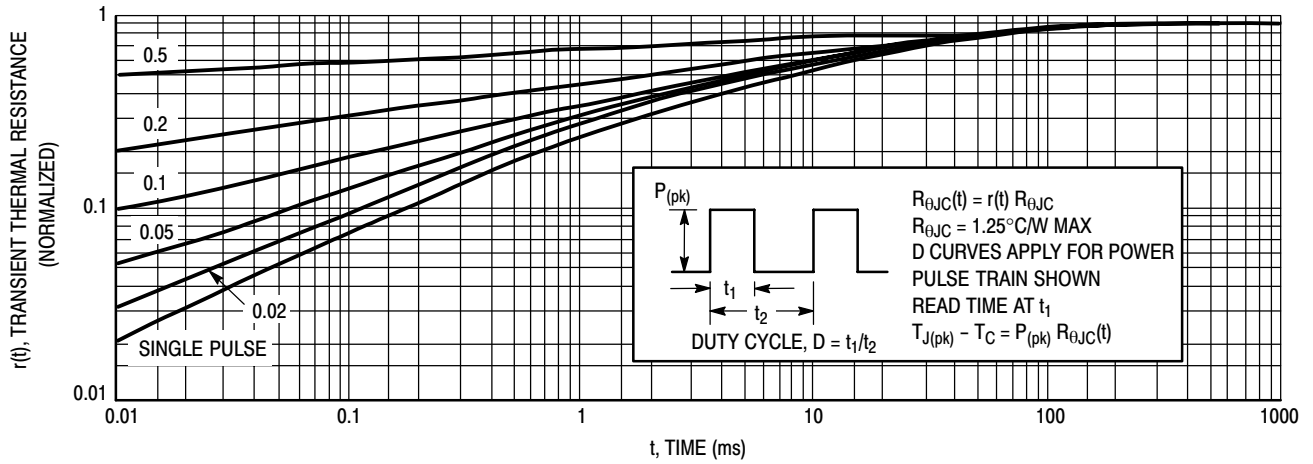
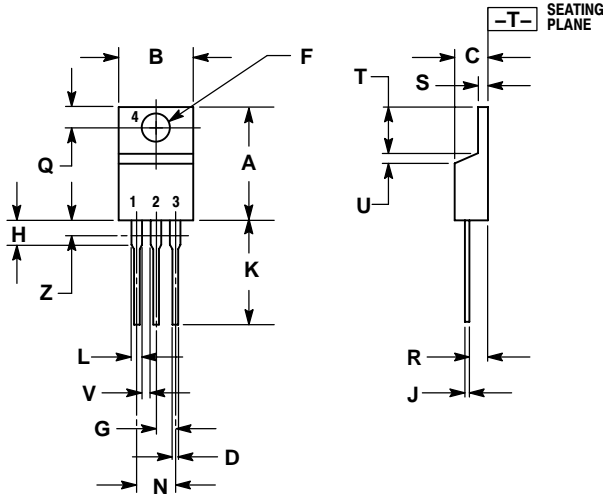


Figure 24. Typical Thermal Response ($Z_{\theta JC}(t)$) for BUH100

BUH100

PACKAGE DIMENSIONS

TO-220AB CASE 221A-09 ISSUE AA



NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.570	0.620	14.48	15.75
B	0.380	0.405	9.66	10.28
C	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
H	0.110	0.155	2.80	3.93
J	0.018	0.025	0.46	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
T	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
V	0.045	---	1.15	---
Z	---	0.080	---	2.04

STYLE 1:

1. BASE
2. COLLECTOR
3. EMITTER
4. COLLECTOR

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